

## Lecture three

Q1) For the n channel MOS transistor shown in figure (1), the threshold voltage  $V_T$  is  $0.8\text{ V}$ . Neglect the channel length modulation effects  $\lambda$ . When the drain voltage  $V_D = 1.6\text{ V}$ , the drain current  $I_D = 0.5\text{ mA}$ . If  $V_D$  is adjusted to be  $2.0\text{ V}$  by changing the value of  $R$  and  $V_{DD}$ , what is the value of drain current  $I_D$  in  $\text{mA}$ ?

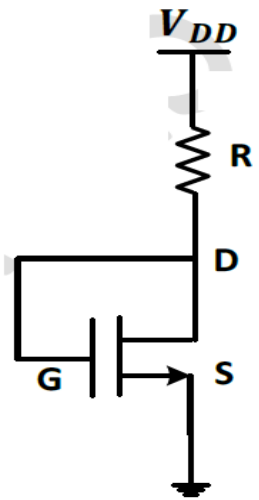


Figure (1) NMOS

Solution:-

Given:-

$$V_T = 0.8 V, V_{D1} = 1.6 V, V_{D2} = 2.0 V, I_{DS1} = 0.5 mA, \lambda = 0$$

For given figure we notice that gate connected to drain to gate so

$$V_{GS} = V_{DS} = V_D$$

In saturation  $I_D$  is given by:-

$$I_{DS} = \frac{1}{2} \mu_n C_{OX} \frac{W_n}{L_n} (V_{GS2} - V_T)^2 (1 + \lambda V_{DS})$$

$$I_{DS} = K (V_{GS} - V_T)^2$$

$$\frac{I_{DS2}}{I_{DS1}} = \frac{K(V_{GS2} - V_T)^2}{K(V_{GS1} - V_T)^2}$$

$$\frac{I_{DS2}}{I_{DS1}} = \frac{(2.0 - 0.8)^2}{(1.6 - 0.8)^2} = 2.25$$

$$I_{DS2} = 2.25 \times 0.5 = 1.125 \text{ mA}$$

Q2) An enhancement N-type transistor  $V_T = 0.7 V$  has its source terminal grounded and  $1.5 V$  applied to the gate. In what region does the device operate for:-

a-  $V_D = 0.5V$  , b-  $V_D = 1.5V$  c-  $V_D = 3.0V$  ?

Solution:-

$$V_T = 0.7 V \quad V_S = 0.0V \quad , \quad V_G = 1.5V$$

$$\text{a- } V_D = 0.5V \quad , \quad V_{DS} = 0.5V \quad , \quad V_{GS} = 1.5V$$

$$V_{GS} - V_T = 1.5V - 0.7V = 0.8V \quad , \quad V_{DS} = 0.5V \quad ,$$

$$V_{DS} < V_{GS} - V_T \quad (\text{Ohmic Region})$$

b-  $V_D = 1.5V$  ,  $V_{D_S} = 1.5V$  ,  $V_{G_S} = 1.5V$

$$V_{G_S} - V_T = 1.5V - 0.7V = 0.8V , V_{D_S} = 1.5V$$

$$V_{D_S} > V_{G_S} - V_T \text{ (Saturation Region)}$$

c-  $V_D = 3.0V$  ,  $V_{D_S} = 3.0V$  ,  $V_{G_S} = 1.5V$

$$V_{G_S} - V_T = 1.5V - 0.7V = 0.8V , V_{D_S} = 3.0V$$

$$V_{D_S} > V_{G_S} - V_T \text{ (Saturation Region)}$$

Q3) When gate to source voltage ( $V_{GS}$ ) of a MOSFET with threshold voltage ( $V_T$ ) of  $= 400.mV$ , working in the saturation is  $900.mV$ , the drain current is observed to be  $1.0 mA$ . Neglecting the channel width modulation effect and assuming that the MOSFET is operating at saturation, What is the value of the drain current for an applied  $V_{GS}$  of  $1400.mV$ ?



Solution:-

$$V_T = 400. \text{mV} \rightarrow V_T = 0.4 \text{ V}$$

$$\text{Voltage applied at gate } V_{GS} = 900. \text{mV} = 0.9 \text{ V}$$

$$I_{DS} = 1 \text{ mA}$$

Find the drain current for

$$V_{GS} = 1400. \text{mV}$$

MOSFET is operating in saturation

$$I_{DS} = K(V_{GS} - V_T)^2$$

$$1 \times 10^{-3} = K(0.9 - 0.4)^2$$

$$K = \frac{1 \times 10^{-3}}{(0.5)^2} = 4 \times 10^{-3} \frac{A}{V^2}$$

For  $V_{GS} = 1.4 V$

$$I_{DS} = K(V_{GS} - V_T)^2$$

$$I_{DS} = 4 \times 10^{-3} \times (1.4 - 0.4)^2 = 4 \text{ mA}$$

Q4) In CMOS inverter shown if transconductance parameters of NMOS and PMOS transistor are:-

$$K_n = K_p = M_n C_{OX} \frac{W_n}{L_n} = M_p C_{OX} \frac{W_p}{L_n} = 40 \text{ MA/V}^2$$

And threshold voltage  $V_T = 1.0 \text{ V}$  what is the value of current  $I$  ?

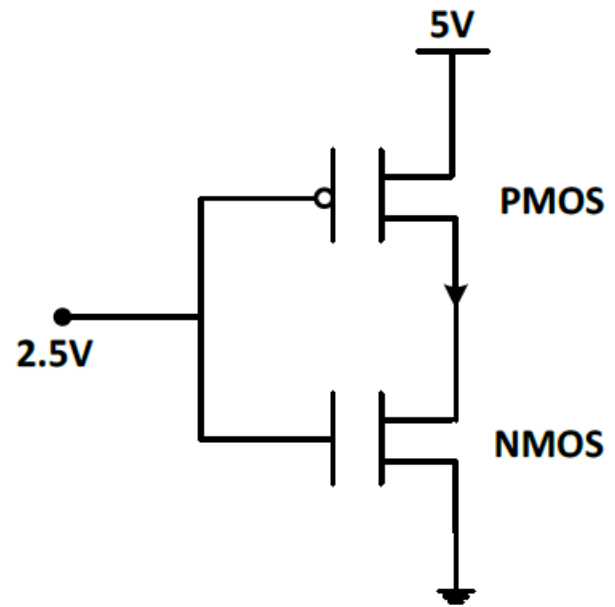


Figure (2)  
CMOS

Solution:-

$$K_n = K_p = 40 \text{ MA/V}^2$$

$$V_T = 1.0 \text{ V}$$

The device is in saturation. So the current is given by:-

$$I_{DS} = K(V_{GS} - V_T)^2$$

$$I_{DS} = \frac{40}{2} (2.5 - 1)^2 = 45 \text{ MA}$$

Q5) In the circuit shown in figure(3) both enhancement mode NMOS transistors have the following characteristics :-  $K_n = M_n C_{OX} \frac{W_n}{L_n} = 1 \text{ mA/V}^2$ ,  $V_T = 1.0 \text{ V}$ . Assume that the channel length modulation parameter  $\lambda$  is zero and the body is shorted to source. What is the minimum supply voltage  $V_{DD}$  (in volts) needed to ensure that transistor  $M_1$  operates in saturation mode of operation?

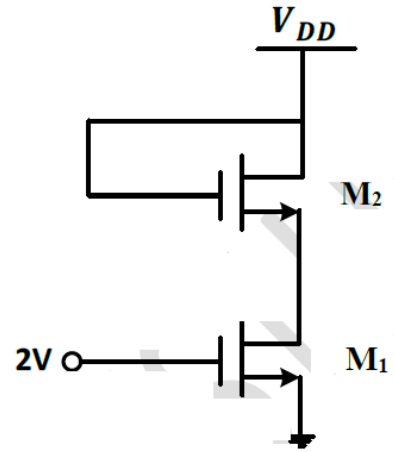


Figure (3)  
NMOS

Solution:-

In the given circuit  $M_1$  operates in saturation. Both MOSFET are NMOS

$$K_n = M_n C_{OX} \frac{W_n}{L_n} = 1 \text{ mA} / V^2$$

$$V_T = 1.0 \text{ V}$$

Both MOSFETs are in series so the same current will flow through them.

$$\text{For } M_1 \quad V_{GS1} = 2 \text{ V}$$

If  $M_1$  is assumed in saturation, then

$$I_{D1} = \frac{1}{2} K_n (V_{GS1} - V_T)^2$$



Minimum  $V_{DS1}$  required for  $M_1$  to operate in saturation

$$V_{DS1} = V_{GS1} - V_T = 2 - 1 = 1V$$

For  $M_2$

$$V_{DD} = V_{GS2} + V_{DS1} \rightarrow V_{GS2} = V_{DD} - 1$$

$$I_{D2} = \frac{1}{2} K_n (V_{GS2} - V_T)^2$$

$$I_{D1} = I_{D2}$$

$$\frac{1}{2} K_n (V_{GS1} - V_T)^2 = \frac{1}{2} K_n (V_{GS2} - V_T)^2$$

$$V_{GS1} - V_T = V_{GS2} - V_T$$

$$V_{GS1} = V_{GS2}$$

$$2 = V_{DD} - 1$$

$$V_{DD} = 3V$$

Q6) The current in enhancement mode NMOS transistor biased in saturation mode was measured to be  $1\text{ mA}$  at drain source voltage  $5\text{ V}$ . When the drain source voltage was increased to  $6\text{ V}$  while keeping gate source voltage same. The drain current increased to  $1.02\text{ mA}$ . What is the value of the channel length modulation parameter?

Solution:-

N MOS transistor

Biased in saturation  $I_D$  ,  $V_{DS} = 5\text{ V}$

Drain current in saturation including the effect of channel length modulation parameter  $\lambda$

$$I_D = \frac{1}{2} \mu_n C_{OX} \frac{W_n}{L_n} (V_{GS2} - V_T)^2 (1 + \lambda V_{DS})$$

So, we can write the ratio of two current

$$\frac{I_{D2}}{I_{D1}} = \frac{1 + \lambda V_{DS2}}{1 + \lambda V_{DS1}}$$

$$\frac{1.02}{1} = \frac{1 + 6\lambda}{1 + 5\lambda}$$

$$1.02 + 5.1\lambda = 1 + 6\lambda$$

$$0.02 = 0.9\lambda$$

$$\lambda = \frac{0.02}{0.9} = 0.022 \text{ V}^{-1}$$

Q7) Consider an n-channel MOSFET with gate source voltage ( $V_{GS} = 1.8$  V). Assume that  $\frac{W_n}{L_n} = 4$ ,  $M_n C_{OX} = 70 \times 10^{-6} \text{ AV}^{-2}$

The threshold voltage is 0.3 V, and the channel length modulation parameter is  $0.09 \text{ V}^{-1}$ . In saturation region what is the value of the drain conduction  $\left(\frac{\partial I_D}{\partial V_{DS}}\right)$  (in micro Siemens)

Solution:-

Given:-

N MOSFET

$$V_{GS} = 1.8 \text{ V}, \frac{W_n}{L_n} = 4, M_n C_{OX} = 70 \times 10^{-6} \text{ AV}^{-2}, V_{TN} = 0.3 \text{ V}, \lambda = 0.09 \text{ V}^{-1}$$

$$I_D = \frac{1}{2} M_n C_{OX} \frac{W_n}{L_n} (V_{GS} - V_T)^2 (1 + \lambda V_{DS})$$

$$g_d = \frac{\partial I_D}{\partial V_{DS}} = \frac{1}{2} M_n C_{OX} \frac{W_n}{L_n} (V_{GS} - V_T)^2 \lambda$$

$$g_d = \frac{1}{2} \times 70 \times 10^{-6} \times 4 \times (1.8 - 0.3)^2 \times 0.09$$

$$g_d = 28.35 \times 10^{-6}$$

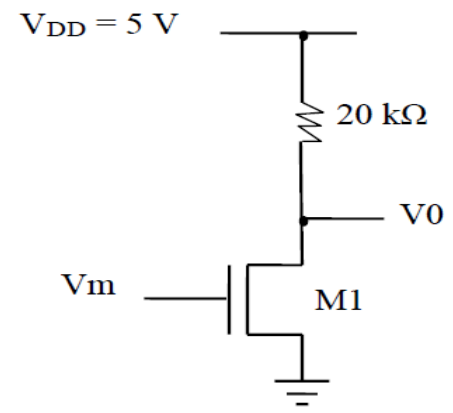
$$g_d = 28.35 \mu \text{ siemens}$$



Q8) For  $M_1$  MOSFET transistor shown in figure (4),  $K_n = 25 \mu A/V^2$ ,  $V_T = 1.0 V$ ,  $\lambda = 0$ , when  $V_m = 5.0 V$ ,  $V_o = 1.0 V$ . Determine:-

a- Transistor mode of operation.

b- Transistor  $\frac{W}{L}$  ratio



Solution:-

Given

$$K_n = 25 \mu\text{A}/\text{V}^2, V_T = 1.0 \text{ V}, \lambda = 0, \text{ when } V_m = 5.0 \text{ V}, V_o = 1.0 \text{ V}$$

$$V_{DS} = V_o = 1.0 \text{ V}$$

$$V_{GS} = V_m = 5.0 \text{ V}$$

$$V_{GS} - V_T = 5.0 - 1.0 = 4.0 \text{ V}, V_{DS} = 1.0 \text{ V}$$

$$V_{DS} < V_{GS} - V_T \rightarrow \text{Ohmic mode}$$

In Ohmic mode the current

$$I_{DS} = \frac{V_{DD} - V_o}{R}$$

$$I_{DS} = \frac{5 - 1}{20} = 0.2 \text{ mA}$$

$$I_{DS} = K_N \frac{W}{L} \left( V_{GS} - V_T - \frac{V_{DS}}{2} \right) V_{DS}$$

$$200 \mu\text{A} = 25 \mu\text{A}/\text{V}^2 \times \frac{W}{L} \times \left( 5 - 1 - \frac{1}{2} \right) \text{V} \times 1 \text{V}$$

$$\frac{W}{L} = 2$$